Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination O'DONNELL ET AL.	
09/749,921		
Examiner	Art Unit	
Binh X. Tran	1765	

Binh X. Tran

SEARCHED					
Class	Subclass	Date	Examiner		
156	345.33	4/11/2005	BT		
156	345.37	4/11/2005	5		
156	345.47	4/11/2005	灯		
156	345.51	4/11/2005	竹		
156	345.52	4/11/2005	135		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	1			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Update search using EAST	4/11/2005	B+		